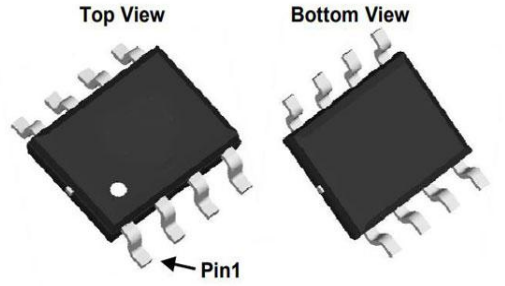
General Description

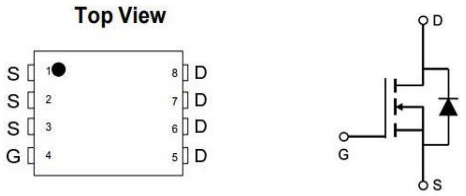
30V /10A Power MOSFET

Very low on-resistance RDS(on) @ VGS=4.5 V

Pb-free lead plating; RoHS compliant

V_{DS}	30	V
$R_{DS(on),TYP@VGS=10V}$	18.2	mΩ
$R_{DS(on),TYP@VGS=4.5}$	28.6	mΩ
I_D	10	A





Part ID	Package Type	Marking	Tape and reel infomation
AC10N03C	SOP8	10N03	3000

100% UIS Tested
100% Rg Tested

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	20	±V
Continuous Drain Current A	T_A=25°C	I_D	10.0	A
	T_A=70°C		7.5	
Pulsed Drain Current B		I_{DM}	16.0	
Avalanche Current G		I_{AR}	3.2	
Repetitive avalanche energy L=0.1mH G		E_{AR}	7.4	mJ
Power Dissipation A	T_A=25°C	P_D	3.1	W
	T_A=70°C		2	
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics

Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	65	97	°C/W
Maximum Junction-to-Ambient A	Steady State		130	156	°C/W
Maximum Junction-to-Lead C	Steady State	$R_{\theta JL}$	39	62	°C/W

STATIC PARAMETERS

Symbol	Parameter	Conditions	Min	Typ	Max	Units
BV_{DSS}	Drain-Source Breakdown Voltage	I_D = -250υA, V_{GS} = 0V	30			V
I_{DSS}	Zero Gate Voltage Drain Current	VDS=30V, VGS=0V			1	uA
					5	
I_{GSS}	Gate-Body leakage current	V_{DS} = 0V, V_{GS} = ±20V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS} I_D = 250∝A	1.3	1.9	2.5	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	VGS=-10V, ID=10A		18.2	26.0	mΩ
		VGS=4.5V, ID=10A		28.6	37.2	
g_{FS}	Forward Transconductance	VDS=5V, ID=10A		51		S
V_{SD}	Diode Forward Voltage	IS=1A,VGS=46V		0.72	1	V
I_S	Maximum Body-Diode Continuous Current				10	A

DYNAMIC PARAMETERS

Symbol	Parameter	Conditions	Min	Typ	Max	Units
C_{iss}	Input Capacitance	VGS=0V, VDS=15V, f=1MHz		550	671	pF
C_{oss}	Output Capacitance			110	135	pF
C_{rss}	Reverse Transfer Capacitance			55	65	pF
R_g	Gate resistance	VGS=0V, VDS=0V, f=1MHz			1.1	Ω

SWITCHING PARAMETERS

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Q_g (10V)	Total Gate Charge	VGS=10V, VDS=15V, ID=10A		4.6		nC
Q_g 4.5V)	Total Gate Charge			2.3		
Q_{gs}	Gate Source Charge			1.54		
Q_{gd}	Gate Drain Charge			2.2		
$t_{D(on)}$	Turn-On DelayTime	VGS=10V, VDS=15V,RL=0.75Ω, RGEN=3Ω		11		ns
t_r	Turn-On Rise Time			8.8		
$t_{D(off)}$	Turn-Off DelayTime			30.8		
t_f	Turn-Off Fall Time			9.9		
t_{rr}	Body Diode Reverse Recovery Time	I_F=-8A, dI/dt=500A/∝s		22		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I_F=18A, dI/dt=500A/∝s		14		nC

CAL ELECTRICAL AND THERMAL CHARACTERISTICS

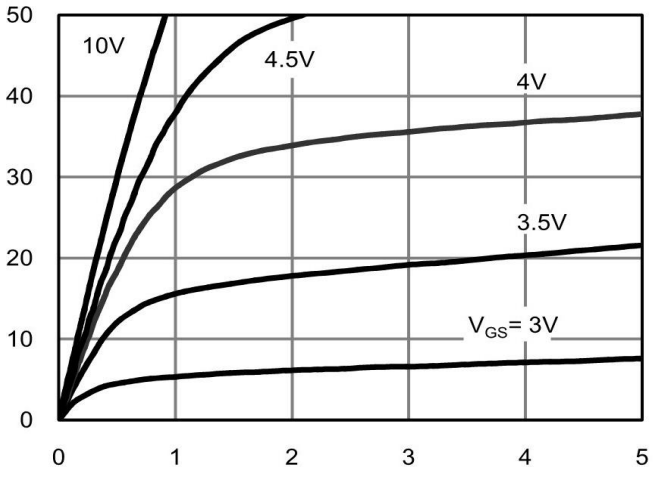


Figure 1: On-Region Characteristics

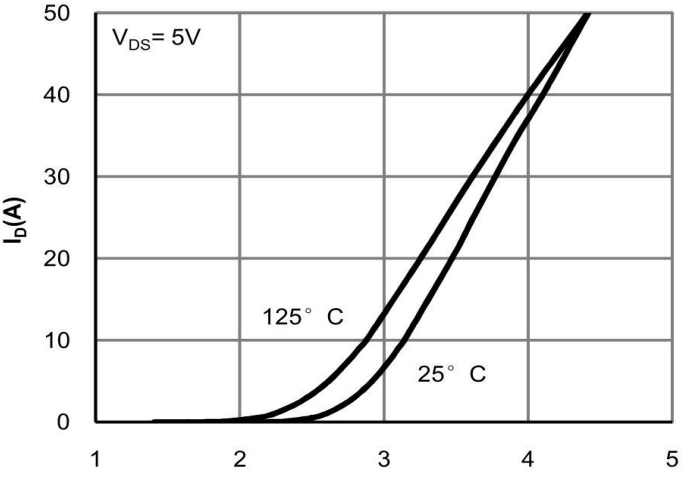


Figure 2: Transfer Characteristics

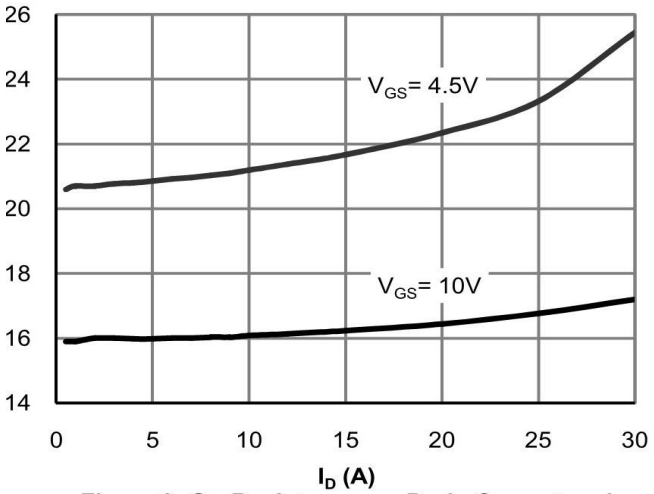


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

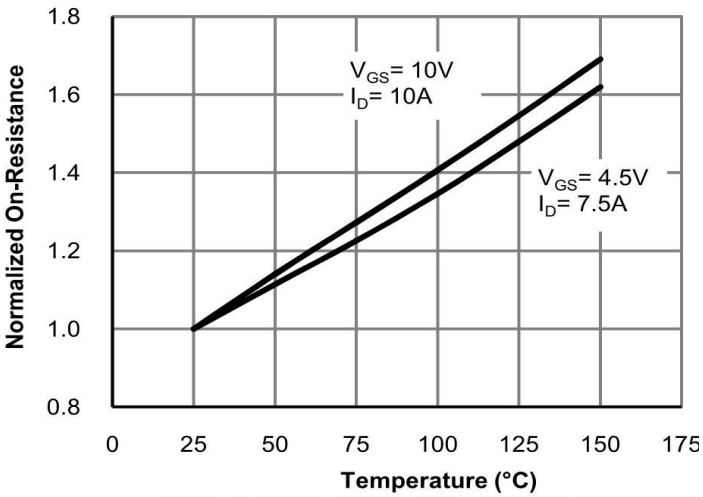
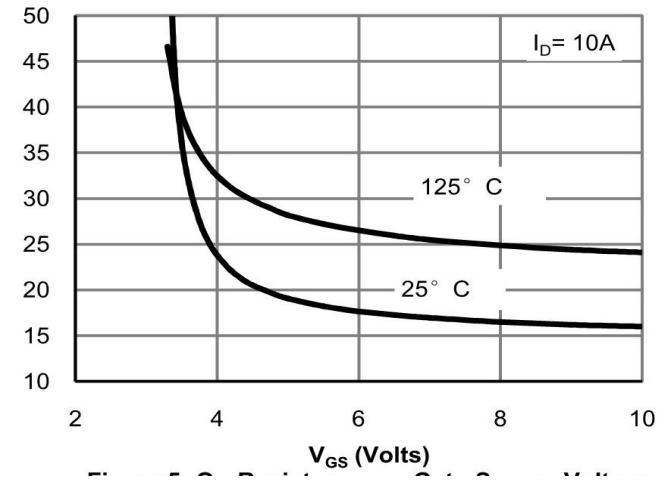
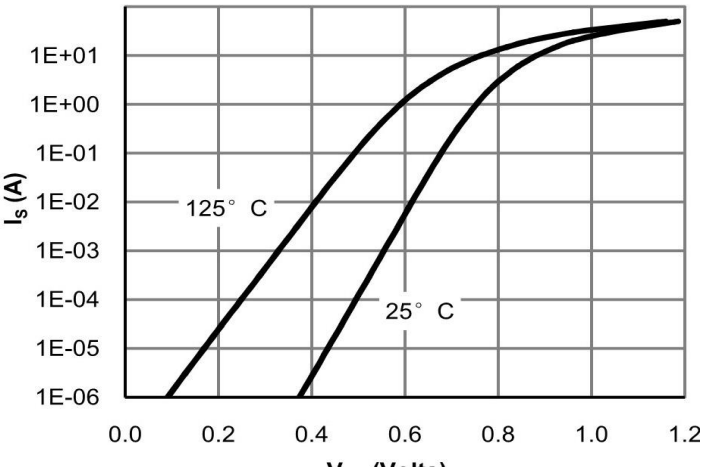


Figure 4: On-Resistance vs. Junction Temperatu





CAL ELECTRICAL AND THERMAL CHARACTERISTICS

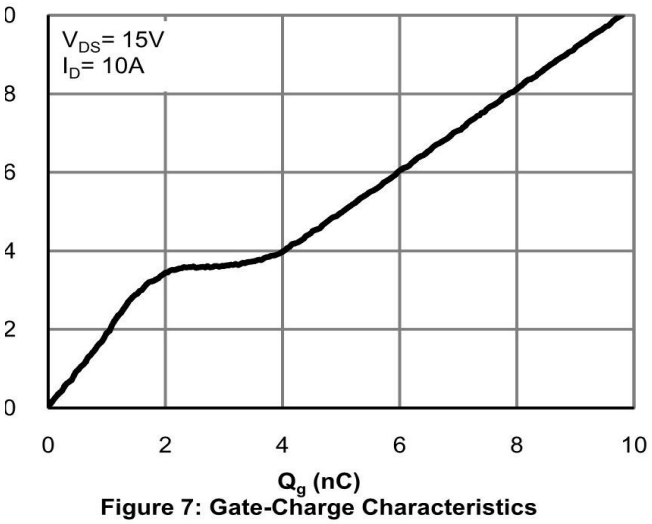


Figure 7: Gate-Charge Characteristics

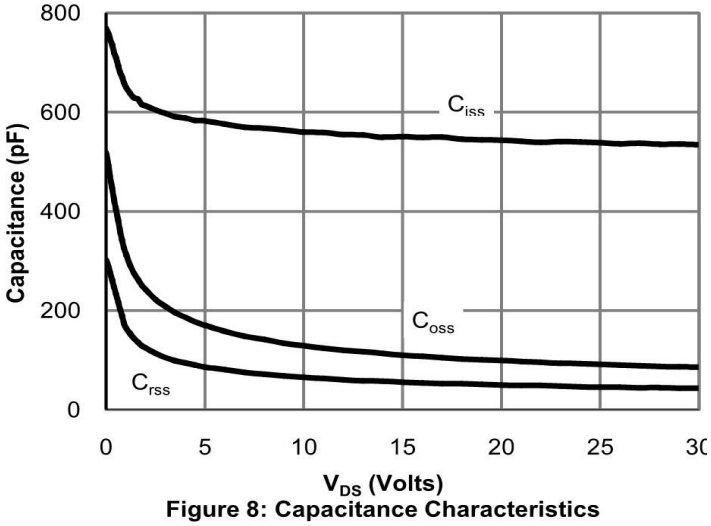


Figure 8: Capacitance Characteristics

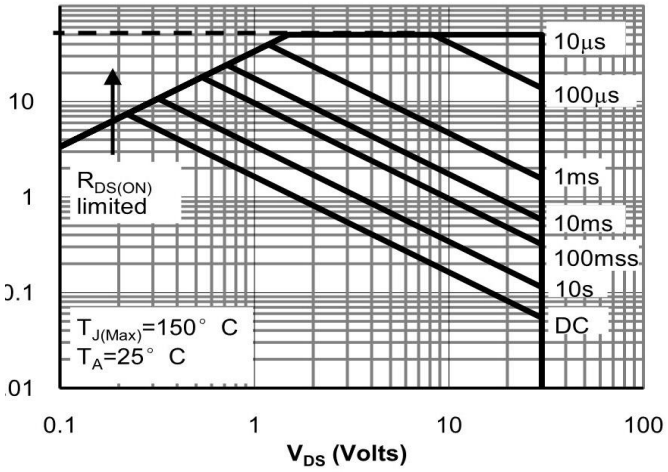


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

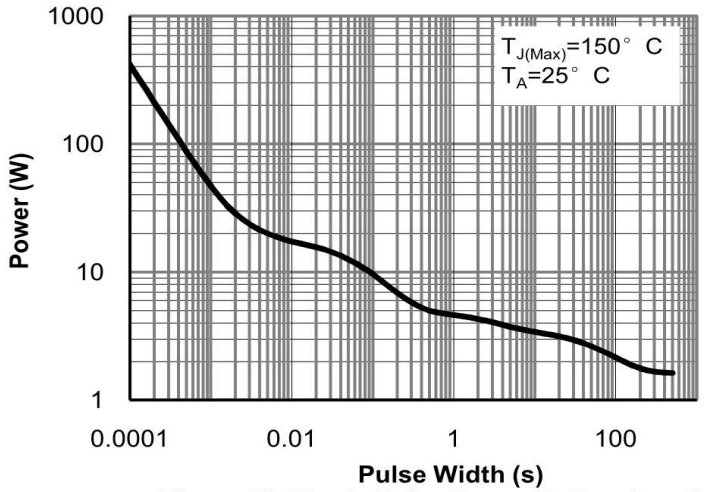
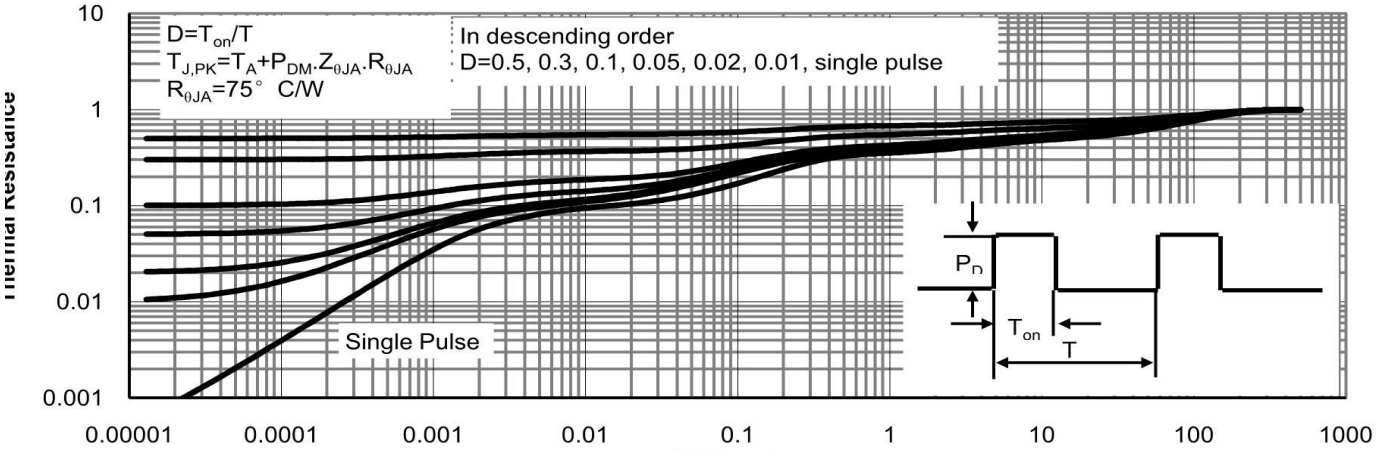
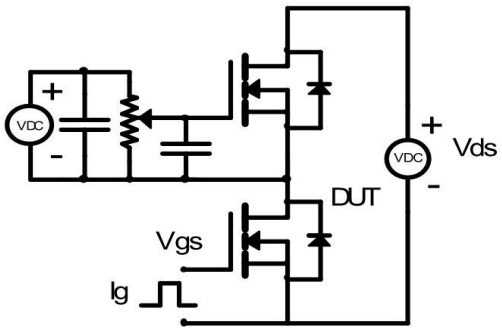
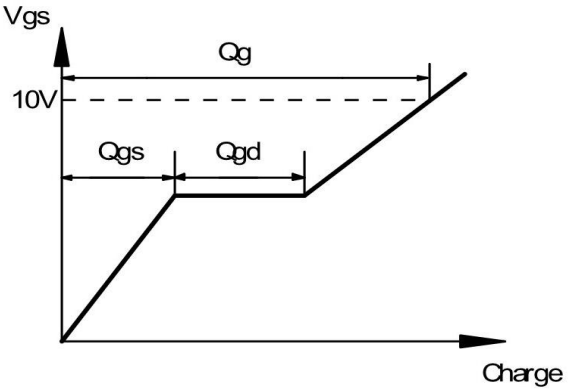


Figure 10: Single Pulse Power Rating Junctic to-Ambient (Note E)

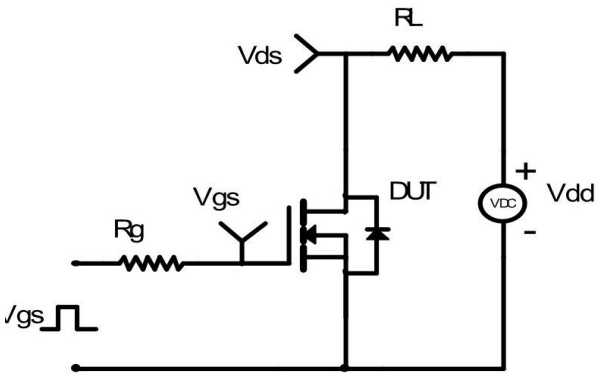


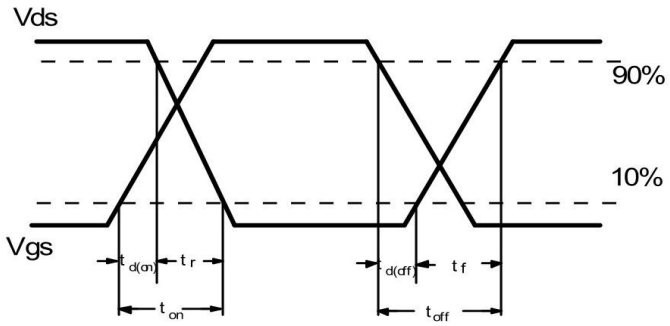
Gate Charge Test Circuit & Waveform



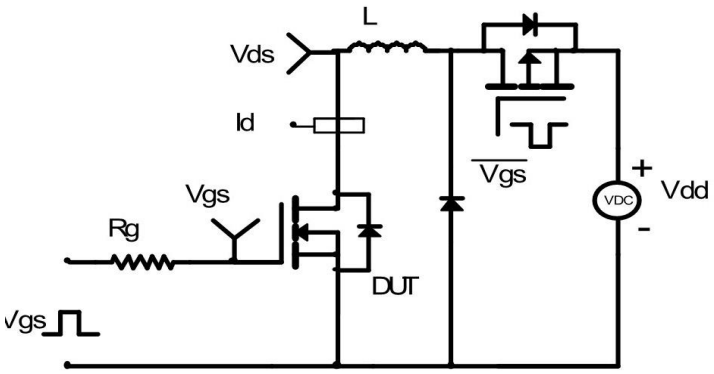


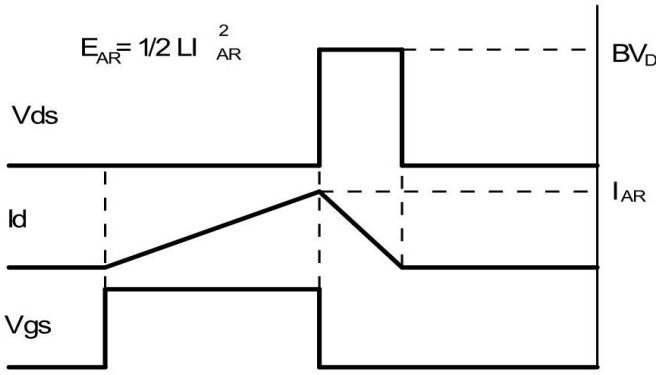
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms